TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE UPOWER OPERATIONAL AMPLIFIERS

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- Excellent Output Drive Capability $V_O = \pm 2.5 \text{ V Min at R}_L = 100 \Omega$, $V_{CC\pm} = \pm 5 \text{ V}$ $V_O = \pm 12.5 \text{ V Min at R}_L = 600 \Omega$, $V_{CC+} = \pm 15 \text{ V}$
- Low Supply Current . . . 280 μA Typ
- Decompensated for High Slew Rate and Gain-Bandwidth Product

 A_{VD} = 0.5 Min Slew Rate = 10 V/ μ s Typ Gain-Bandwidth Product = 6.5 MHz Typ

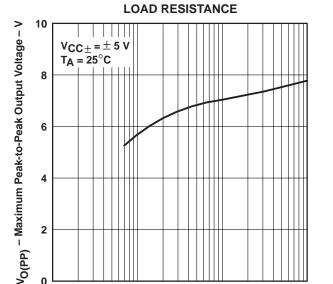
description

The TLE2161, TLE2161A, and TLE2161B are JFET-input, low-power, precision operational amplifiers manufactured using the Texas Instruments Excalibur process. Decompensated for stability with a minimum closed-loop gain of 5, these devices combine outstanding output drive capability with low power consumption, excellent dc precision, and high gain-bandwidth product.

In addition to maintaining the traditional JFET advantages of fast slew rates and low input bias and offset currents, the Excalibur process offers outstanding parametric stability over time and temperature. This results in a device that remains precise even with changes in temperature and over years of use.

- Wide Operating Supply Voltage Range
 V_{CC ±} = ± 3.5 V to ± 18 V
- High Open-Loop Gain . . . 280 V/mV Typ
- Low Offset Voltage . . . 500 μV Max
- Low Offset Voltage Drift With Time 0.04 μV/Month Typ
- Low Input Bias Current . . . 5 pA Typ

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE



 R_L – Load Resistance – Ω

AVAILABLE OPTIONS

10

			PACK	AGE	
TA	V _{IO} max AT 25°C	SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)
0°C to 70°C	500 μV 1.5 mV 3 mV	— TLE2161ACD TLE2161CD	1 1	1 1	TLE2161BCP TLE2161ACP TLE2161CP
-40°C to 85°C	500 μV 1.5 mV 3 mV	— TLE2161AID TLE2161ID	1 1	1 1	TLE2161BIP TLE2161AIP TLE2161IP
−55°C to 125°C	500 μV 1.5 mV 3 mV	— TLE2161AMD TLE2161MD	— TLE2161AMFK TLE2161MFK	TLE2161BMJG TLE2161AMJG TLE2161MJG	TLE2161BMP TLE2161AMP TLE2161MP

The D packages are available taped and reeled. Add R suffix to device type (e.g., TLE2161ACDR).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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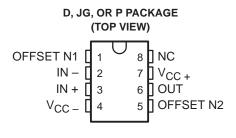
TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE uPOWER OPERATIONAL AMPLIFIERS

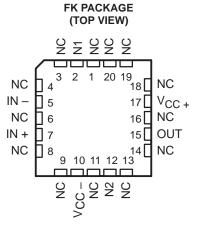
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description (continued)

A variety of available options includes small-outline packages and chip-carrier versions for high-density system applications.

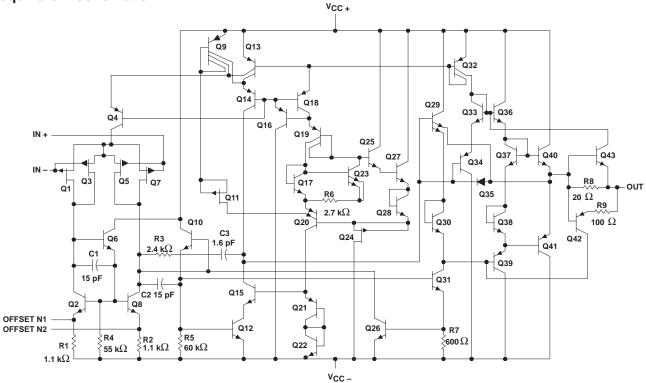
The C-suffix devices are characterized for operation from 0° C to 70° C. The I-suffix devices are characterized for operation from -40° C to 85° C. The M-suffix devices are characterized for operation over the full military temperature range of -55° C to 125° C.





NC - No internal connection

equivalent schematic



All component values are nominal.



TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

	19 V
	80 mA
w) 25°C (see Note 3)	unlimited
	See Dissipation Rating Table
C suffix	0°C to 70°C
I suffix	– 40°C to 85°C
M suffix	– 55°C to 125°C
	– 65°C to 150°C
kage	
case for 10 seconds: D or P package	ge 260°C
case for 60seconds: JG package	300°C
	w) 25°C (see Note 3) C suffix I suffix M suffix kage case for 10 seconds: D or P package

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between V_{CC} +, and V_{CC} -.

- 2. Differential voltages are at IN+ with respect to IN-.
- 3. The output may be shorted to either supply. Temperature and /or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
Р	1000 mW	8.0 mW/°C	640 mW	520 mW	200 mW

recommended operating conditions

		C SUFFIX		I SUFFIX		M SUF	FIX	UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNII
Supply voltage, V _{CC±}		±3.5	±18	±3.5	±18	+3.5	±18	V
Common mode input voltage V.a.	$V_{CC \pm} = \pm 5 V$	-1.6	4	-1.6	4	-1.6	4	V
Common-mode input voltage, V_{IC} $V_{CC \pm = \pm 15 \text{ V}}$		-11	13	-11	13	-11	13	V
Operating free-air temperature, T _A		0	70	-40	85	-55	125	°C



TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D – NOVEMBER 1989 – REVISED MAY 1996

electrical characteristics at specified free-air temperature, V_{CC \pm} = \pm 5 V (unless otherwise noted)

	PARAMETER		TEST CON	IDITIONS	T _A †	TLE2161 TL	C, TLE2 E2161B0		UNIT
						MIN	TYP	MAX	
		TI F04646			25°C		0.8	3.1	
		TLE2161C			Full range			4	
	land offertualisms	TI F0404A0	7		25°C		0.6	2.6	>/
VIO	Input offset voltage	TLE2161AC			Full range			3.5	mV
		TI FOACADO	1		25°C		0.5	1.9	
		TLE2161BC	\/ 0	D- 50.0	Full range			2.4	
ανιο	Temperature coefficient of i	nput offset voltage	$V_{IC} = 0$,	$R_S = 50 \Omega$	Full range		6		μV/°C
	Input offset voltage long-ter	m drift (see Note 4)			25°C		0.04		μV/mo
1	land offert company		1		25°C		1		рΑ
IO	Input offset current				Full range			0.8	nA
	Lament hills a summeral		7		25°C		3		pА
ΙΒ	Input bias current				Full range			2	nA
.,	O				25°C	-1.6 to 4	-2 to 6		V
VICR	Common-mode input voltage	ge range			Full range	-1.6 to 4			V
					25°C	3.5	3.7		
			$R_L = 10 \text{ k}\Omega$		Full range	3.3			.,
+ MOV	Maximum positive peak output voltage swing				25°C	2.5	3.1		V
			$R_L = 100 \Omega$		Full range	2			
					25°C	-3.7	-3.9		
			$R_L = 10 \text{ k}\Omega$		Full range	-3.3			
VOM –	Maximum negative peak ou	itput voltage swing	_		25°C	-2.5	-2.7		V
			$R_L = 100 \Omega$		Full range	-2			
			1, , , , , , , ,	D 4010	25°C	15	80		
			$V_0 = \pm 2.8 \text{ V},$	$R_L = 10 \text{ k}\Omega$	Full range	2			
				D 400 0	25°C	0.75	45		.,, .,
AVD	Large-signal differential vol	age amplification	$V_0 = 0 \text{ to } 2 \text{ V},$	$R_L = 100 \Omega$	Full range	0.5	-		V/mV
				D 400.0	25°C	0.5	3		
			$V_0 = 0 \text{ to } -2 \text{ V},$	$R_L = 100 \Omega$	Full range	0.25			
rį	Input resistance				25°C		1012		Ω
ci	Input capacitance				25°C		4		pF
z ₀	Open-loop output impedance	ce	I _O = 0		25°C		280		Ω
	Common made releasing	tio.	\\\\\\\\\\\\\\\\\\\\\\\\\\\	D= 50.0	25°C	65	82		*1D
CMRR	Common-mode rejection ra	liO	V _{IC} =V _{ICR} min,	KS = 20.0	Full range	65			dB
kas :=	Cumply voltage rejection and	io (A)/o = -/4)/o = \	$V_{CC\pm} = \pm 5 \text{ V t}$	o ±15 V.	25°C	75	93		410
ksvr	Supply-voltage rejection rat	ιο (σλCC∓ \σλΙΟ)	$R_S = 50 \Omega$,	Full range	75			dB
1	Committee accomment				25°C		280	325	^
ICC	Supply current		\\o = 0	No load	Full range			350	μΑ
ΔlCC	Supply-current change ove temperature range	roperating	$V_O = 0$,	ino ioad	Full range		29		μΑ

[†] Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D – NOVEMBER 1989 – REVISED MAY 1996

operating characteristics at specified free-air temperature, V $_{\text{CC}}\,{}_{\pm}\text{=}\,{}_{\pm}5$ V (unless otherwise noted)

	PARAMETER	TE	ST CONDITION	NS	T _A †		1C, TLE2 .E2161B		UNIT
						MIN	TYP	MAX	
					25°C	7	10		
SR	Slew rate (see Figure 1)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$,	C _L = 100 pF	Full range	5			V/μs
\ <u></u>	Equivalent input noise voltage	$R_S = 20 \Omega$,	f = 10 Hz		25°C		59	100	->//s/I-I=
V _n	(see Figure 2)	$R_S = 20 \Omega$,	f = 1 kHz		25 C		43	60	nV/√Hz
V _{n(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10) Hz		25°C		1.1		μV
In	Equivalent input noise current	f = 1 kHz			25°C		1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)} = 2 V$, $R_L = 10 \text{ k}\Omega$	$A_{VD} = 5$,	f = 10 kHz,	25°C		0.025%		
	Gain-bandwidth product	f = 100 kHz,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	25°C		5.8		MHz
	(see Figure 3)	f = 100 kHz,	$R_L = 100 \text{ k}\Omega$,	C _L = 100 pF	25 C		4.3		IVITIZ
	Settling time	ε = 0.1%			25°C		5		
t _S	Settling time	ε = 0.01%			25 C		10		μs
ВОМ	Maximum output-swing bandwidth	A _{VD} = 5,	R _L = 10 kΩ		25°C		420		kHz
φ.	Phone margin (and Figure 2)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	25°C		70°		
Φm	Phase margin (see Figure 3)	$A_{VD} = 5$,	$R_L = 100 \Omega$	C _L = 100 pF	25 0		84°		

[†] Full range is 0°C to 70°C.

TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D – NOVEMBER 1989 – REVISED MAY 1996

electrical characteristics at specified free-air temperature, V $_{\text{CC}\,\pm}$ = \pm 15 V (unless otherwise noted)

	PARAMETER		TEST CON	IDITIONS	T _A †		IC, TLE2 ⁻ .E2161BC		UNIT
						MIN	TYP	MAX	
		TI F04040			25°C		0.6	3	
		TLE2161C			Full range			3.9	
\/. -	Innut offeet voltege	TI F2464AC	1		25°C		0.5	1.5	\/
VIO	Input offset voltage	TLE2161AC			Full range			2.5	mV
		TI F0464BC	1		25°C		0.3	0.5	
		TLE2161BC			Full range			1	
ανιο	Temperature coefficient of	input offset voltage	$V_{IC} = 0$,	$R_S = 50 \Omega$	Full range		6		μV/°C
	Input offset voltage long-te (see Note 4)	rm drift			25°C		0.04		μV/mo
1	Innuit offeet current		1		25°C		2		pА
IIO	Input offset current				Full range			1	nA
1	Innut high oursent		1		25°C		4		pА
ΙΒ	Input bias current				Full range			3	nA
\/	Common mode input volte				25°C	-11 to 13	-12 to 16		V
VICR	Common-mode input volta	ge range			Full range	-11 to 13			V
			D 401-0		25°C	13.2	13.7		
	Marrian and itima and a		$R_L = 10 \text{ k}\Omega$		Full range	13			\ ,,
VOM +	Maximum positive peak ou	itput voitage swing	D. COO.O.		25°C	12.5	13.2		V
			$R_L = 600 \Omega$		Full range	12			
			D. 40 kO		25°C	-13.2	-13.7		
V	Maximum pagativa pagl	utaut valtaga avijag	$R_L = 10 \text{ k}\Omega$		Full range	-13			V
VOM –	Maximum negative peak o	utput voltage swing	P 600 O		25°C	-12.5	-13		V
			$R_L = 600 \Omega$		Full range	-12			
			\/o - +10\/	Pr = 10 kO	25°C	30	230		
			$V_0 = \pm 10 \text{ V},$	$R_L = 10 \text{ k}\Omega$	Full range	20			
۸	Large-signal differential vo	Itago amplification	$V_0 = 0 \text{ to } 8 \text{ V},$	R _L = 600 Ω	25°C	25	100		V/mV
AVD	Large-signal differential vo	itage amplification	νΟ = 0 t0 8 v,	KL = 000 22	Full range	10			V/IIIV
			$V_0 = 0 \text{ to } -8 \text{ V},$	P 600 O	25°C	3	25		
			VO = 0 10 - 8 V,	KL = 000 22	Full range	1			
rį	Input resistance				25°C		1012		Ω
ci	Input capacitance				25°C		4		pF
z _O	Open-loop output impedan	ice	IO = 0		25°C		280		Ω
	Onnana medication	-4:-	V:- V'	D- 50.0	25°C	72	90		4 F
CMRR	Common-mode rejection ra	auo	$V_{IC} = V_{ICRmin}$	$R_S = 50 \Omega$	Full range	70			dB
ka. :-	Cupply voltage rejection	atio (A)/ (A)/-	$V_{CC\pm} = \pm 5 \text{ V to}$	±15 V,	25°C	75	93		40
ksvr	Supply-voltage rejection ra	(¬ΛCC∓ \¬ΛΙΟ)	$RS = 50 \Omega$		Full range	75			dB
1	Cumply ourrant				25°C		290	350	
ICC	Supply current		VO = 0.	No load	Full range			375	μΑ
ΔlCC	Supply-current change over temperature range	er operating	v O = 0,	NO IOAU	Full range		34		μΑ

[†] Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated to $T_A = 25^{\circ}C$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE µPOWER OPERATIONAL AMPLIFIERS SLOS049D - NOVEMBER 1989 - REVISED MAY 1996

operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ± 15 V (unless otherwise noted)

	PARAMETER	TE	ST CONDITION	NS	T _A †		1C, TLE2 .E2161B0		UNIT
						MIN	TYP	MAX	
SR	Slew rate (see Figure 1)	A (D = 5	Pr = 10 kO	C _I = 100 pF	25°C	7	10		V/µs
J SK	Siew rate (see Figure 1)	$A_{VD} = 5$,	RL = 10 Ks2,	CL = 100 pr	Full range	5			ν/μ5
V	Equivalent input noise voltage	$R_S = 20 \Omega$,	f = 10 Hz		25°C		70	100	->//s/I-I=
V _n	(see Figure 2)	$R_S = 20 \Omega$,	f = 1 kHz		25 C		40	60	nV/√Hz
V _{n(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10	Hz		25°C		1.1		μV
In	Equivalent input noise current	f = 1 kHz			25°C		1.1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)} = 2 \text{ V},$ $R_L = 10 \text{ k}\Omega$	$A_{VD} = 5$,	f = 10 kHz,	25°C		0.025%		
	Gain-bandwidth product	f = 100 kHz,	$R_L = 10 \text{ k}\Omega$,	C _L = 100 pF	25°C		6.4		MHz
	(see Figure 3)	f = 100 kHz,	$R_L = 600 \Omega$,	C _L = 100 pF	25 C		5.6		IVITZ
	Cottling time	ε = 0.1%			25°C		5		
t _S	Settling time	ε = 0.01%			25 C		10		μs
ВОМ	Maximum output-swing bandwidth	A _{VD} = 5,	R _L = 10 kΩ		25°C		116		kHz
4	Dhoop margin (and Figure 2)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	25°C		72°		
Φm	Phase margin (see Figure 3)	$A_{VD} = 5$,	$R_L = 600 \Omega$,	C _L = 100 pF	25.0		78°		

[†] Full range is 0°C to 70°C.

TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D – NOVEMBER 1989 – REVISED MAY 1996

electrical characteristics at specified free-air temperature, V $_{\text{CC}}$ $_{\pm}$ = \pm 5 V (unless otherwise noted)

	Input offset voltage TLE2161/ TLE2161/ TLE2161/ TLE2161/ TLE2161/ TLE2161/ TLE2161/ TLE2161/ TLE2161/ Input offset voltage long-term drift (see Note 4) Input offset current Input bias current Common-mode input voltage range Maximum positive peak output voltage Maximum negative peak output voltage swi		TEST CON	IDITIONS	T _A †		11, TLE2 .E2161B		UNIT
					^`	MIN	TYP	MAX	
		TI F04641			25°C		0.8	3.1	
		ILEZIOII			Full range			4.4	
V/10	Input offset voltage	TI E2464 A I	1		25°C		0.6	2.6	mV
VIO	input onset voltage	TLEZIOTAI			Full range			3.9	IIIV
		TI E2161DI	1		25°C		0.5	1.9	
		TEEZTOTBI	_		Full range			2.7	
αVIO			$V_{IC} = 0,$	$R_S = 50 \Omega$	Full range		6		μV/°C
		ft			25°C		0.04		μV/mo
lio.	Input offset current]		25°C		1		pА
lio	input onset current		_		Full range			2	nA
lin	Input hige current		1		25°C		3		pА
lΒ	input bias current				Full range			4	nA
					_	-1.6	-2		
					25°C	to 4	to 6		
VICR	Common-mode input voltage rar	nge				-1.6	0		V
					Full range	-1.6 to			
					l am range	4			
			D 4010		25°C	3.5	3.7		
/014	Maximum positive peak output voltage		$R_L = 10 \text{ k}\Omega$		Full range	3.1			
VOM +			D 400.0		25°C	2.5	3.1		V
			$R_L = 100 \Omega$		Full range	2			
			D 4010		25°C	-3.7	-3.9		
	Markarina		$R_L = 10 \text{ k}\Omega$		Full range	-3.1	-		
VOM –	Maximum negative peak output	voltage swing	D: 400.0		25°C	-2.5	-2.7		V
			$R_L = 100 \Omega$		Full range	-2			
			Va +2.8.V	D. 10 kg	25°C	15	80		
			$V_0 = \pm 2.8 \text{ V},$	$R_L = 10 \text{ k}\Omega$	Full range	2			
۸	Large-signal differential voltage	amplification	$V_{O} = 0 \text{ to } 2 \text{ V},$	P 100 O	25°C	0.75	45		V/mV
AVD	Large-signal differential voltage	amplification	VO = 0.002 V,	KL = 100 12	Full range	0.5			V/IIIV
			$V_0 = 0 \text{ to } -2 \text{ V},$	P 100 O	25°C	0.5	3		
			VO=010-2 V,	KL = 100 22	Full range	0.25			
rį	Input resistance				25°C		1012		Ω
ci	Input capacitance				25°C		4		pF
z _o	Open-loop output impedance		IO = 0		25°C		280		Ω
CMRR	Common-mode rejection ratio		V _{IC} =V _{ICR} min,	Pa = 50.0	25°C	65	82		dB
CIVIKK	Common-mode rejection ratio		VIC=VICRIIIIII,	1/8 = 20 77	Full range	65			ub
kovo	Supply-voltage rejection ratio (A)	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	$V_{CC\pm} = \pm 5 \text{ V to}$	± 15 V,	25°C	75	93		dB
ksvr	Supply-voltage rejection ratio (Δ	ν CC± /ΔVIO)	$R_S = 50 \Omega$		Full range	65			UD
loc	Supply current				25°C		280	325	^
Icc	Supply current		$V_0 = 0$,	No load	Full range			350	μΑ
ΔlCC	Supply-current change over ope temperature range	rating] 10 - 0,	NO IOAU	Full range		29		μА

[†] Full range is – 40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated to TA= 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE µPOWER OPERATIONAL AMPLIFIERS SLOS049D - NOVEMBER 1989 - REVISED MAY 1996

operating characteristics at specified free-air temperature, V $_{\text{CC}}$ $_{\pm}$ = \pm 5 V (unless otherwise noted)

	PARAMETER	TE	ST CONDITIO	NS	T _A †	TLE2161I, TLE2161AI TLE2161BI			UNIT
						MIN	TYP	MAX	
SR	Slew rate (see Figure 1)	A _{VD} = 5,	$R_I = 10 \text{ k}\Omega$	C _I = 100 pF	25°C	7	10		V/µs
SIX	Siew rate (see rigule 1)	AVD = 3,	N_ = 10 Ks2,	CL = 100 pr	Full range	5			ν/μ5
V	Equivalent input noise	$R_S = 20 \Omega$,	f = 10 Hz		25°C		59	100	nV/√ Hz
V _n	voltage (see Figure 2)	$R_S = 20 \Omega$,	f = 1 kHz		25 C		43	60	IIV/∀⊓Z
V _{n(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10) Hz		25°C		1.1		μV
In	Equivalent input noise current	f = 1 kHz			25°C		1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)} = 2 \text{ V},$ $R_L = 10 \text{ k}\Omega$	$A_{VD} = 5$,	f = 10 kHz,	25°C		0.025%		
	Gain-bandwidth product	f = 100 kHz,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	25°C		5.8		MHz
	(see Figure 3)	f = 100 kHz,	$R_L = 100 \Omega$,	C _L = 100 pF	25 C		4.3		IVITZ
	Settling time	ε = 0.1%			25°C		5		
t _S	Setting time	ε = 0.01%			25 C		10		μs
ВОМ	Maximum output-swing bandwidth	A _{VD} = 5,	R _L = 10 kΩ		25°C		420		kHz
4	Phone margin (and Figure 2)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	25°C		70°		
φm	Phase margin (see Figure 3)	$A_{VD} = 5$,	$R_L = 100 \Omega$,	C _L = 100 pF] 25 0		84°		

[†] Full range is – 40°C to 85°C.

TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE µPOWER OPERATIONAL AMPLIFIERS

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electrical characteristics at specified free-air temperature, V_{CC \pm} = \pm 15 V (unless otherwise noted)

	PARAMETER	1	TEST CON	IDITIONS	T _A †		11, TLE2 E2161B		UNIT
					^	MIN	TYP	MAX	
		TI FOACAI			25°C		0.6	3	
		TLE2161I			Full range			4.3	
\	lanut effect veltere	TI FOACAAI	1		25°C		0.5	1.5	\/
VIO	Input offset voltage	TLE2161AI			Full range			2.9	mV
		TI FOACADI	1		25°C		0.3	0.5	
		TLE2161BI	\/.a 0	D- 50.0	Full range			1.3	
ανιο	Temperature coefficient of	input offset voltage	$V_{IC} = 0,$	$R_S = 50 \Omega$	Full range		6		μV/°C
	Input offset voltage long-te	rm drift (see Note 4)]		25°C		0.04		μV/mo
l.o	Input offeet ourrent		1		25°C		2		pА
lio	Input offset current				Full range			3	nA
l.s	Input bigg ourrent		1		25°C		4		pА
IB	Input bias current				Full range			5	nA
Vion	Common-mode input volta	go rango			25°C	-11 to 13	-12 to 16		V
VICR	Common-mode input voita	ge range			Full range	-11 to 13			V
			D: 40 kO		25°C	13.2	13.7		
\/	Marrian na sitir a maratrar	de de la companya de	$R_L = 10 \text{ k}\Omega$		Full range	13		V	
VOM +	Maximum positive peak ou	itput voitage swing	D: C00 O		25°C	12.5	13.2		V
			$R_L = 600 \Omega$		Full range	12			
			R _L = 10 kΩ		25°C	-13.2	-13.7		
\/a	Maximum negative peak o	utout voltogo owing	KL = 10 KS2		Full range	-13			V
VOM –	waximum negative peak o	utput voltage swing	R _L = 600 Ω		25°C	-12.5	-13		V
			KL = 000 22		Full range	-12			
			$V_0 = \pm 10 \text{ V},$	R _L = 10 kΩ	25°C	30	230		
			V ₀ = ± 10 V,	NC = 10 K22	Full range	20			
۸۰۰	Large-signal differential vo	Itage amplification	$V_0 = 0 \text{ to } 8 \text{ V},$	P 600 O	25°C	25	100		V/mV
AVD	Large-signal differential vo	itage amplification	v ₀ = 0 to 8 v,	NC = 000 22	Full range	10			V/111V
			$V_0 = 0 \text{ to} - 8 \text{ V},$	Rt = 600 O	25°C	3	25		
			V0 = 0 to 0 V,	11 = 000 32	Full range	1			
rį	Input resistance				25°C		10 ¹²		Ω
ci	Input capacitance				25°C		4		pF
z _o	Open-loop output impedan	ice	I _O = 0		25°C		280		Ω
CMRR	Common-mode rejection ra	atio	V _{IC} =V _{ICR} min,	R _S = 50 Ω	25°C Full range	72 65	90		dB
ksvr	Supply-voltage rejection ra	atio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm} = \pm 5 \text{ V to}$ $R_S = 50 \Omega$	±15 V,	25°C Full range	75 65	93		dB
	-		 		25°C	<u> </u>	290	350	
ICC	Supply current		V _O = 0,	No load	Full range			375	μΑ
∆ICC	Supply-current change over temperature range	er operating			Full range		34		μΑ

[†] Full range is – 40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150$ °C extrapolated to $T_A = 25$ °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D - NOVEMBER 1989 - REVISED MAY 1996

operating characteristics at specified free-air temperature, V $_{CC~\pm}$ = \pm 15 V (unless otherwise noted)

	PARAMETER	TE	ST CONDITION	NS	T _A †	TLE2161I, TLE2161AI TLE2161IB			UNIT
					"	MIN	TYP	MAX	
SR	Slew rate (see Figure 1)	A. 45 – E	Pr = 10 kO	C _I = 100 pF	25°C	7	10		V/μs
J SIX	Siew rate (see Figure 1)	$A_{VD} = 5$,	KL = 10 KS2,	CL = 100 pr	Full range	5			ν/μ5
\ /	Equivalent input noise voltage	$R_S = 20 \Omega$,	f = 10 Hz		25°C		70	100	-> //s/II=
Vn	(see Figure 2)	$R_S = 20 \Omega$,	f = 1 kHz		25 C		40	60	nV/√Hz
V _{n(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10	Hz		25°C		1.1		μV
In	Equivalent input noise current	f = 1 kHz			25°C		1.1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)} = 2 V$, $R_L = 10 \text{ k}\Omega$	A _{VD} = 5,	f = 10 kHz,	25°C		0.025%		
	Gain-bandwidth product	f = 100 kHz,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	25°C		6.4		MHz
	(see Figure 3)	f = 100 kHz,	$R_L = 600 \Omega$,	C _L = 100 pF	25 C		5.6		IVITZ
	Settling time	ε = 0.1%			25°C		5		
t _S	Settling time	ε = 0.01%			25 C		10		μs
ВОМ	Maximum output-swing bandwidth	A _{VD} = 5,	R _L = 10 kΩ		25°C		116		kHz
Α	Phase margin (see Figure 3)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	25°C		72°		
Φm	rnase margin (see rigule 3)	$A_{VD} = 5$,	$R_L = 600 \Omega$	C _L = 100 pF	200		78°		

[†] Full range is – 40°C to 85°C.

TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D – NOVEMBER 1989 – REVISED MAY 1996

electrical characteristics at specified free-air temperature, V_{CC \pm} = \pm 5 V (unless otherwise noted)

	PARAMETER		TEST CON	DITIONS	T _A †	TL	E2161N E2161AI E2161BI	M	UNIT
						MIN	TYP	MAX	
		TI FOACANA			25°C		0.8	3.1	
		TLE2161M			Full range			6	
V -	Innut offeet voltage	TI F2464 AM	7		25°C		0.6	2.6	mV
VIO	Input offset voltage	TLE2161AM			Full range			4.6	IIIV
		TLE2161BM			25°C		0.5	1.9	
		TLEZ TO I BIVI			Full range			3.1	
αΛΙΟ	Temperature coefficient of i voltage	nput offset	V _{IC} = 0,	$R_S = 50 \Omega$	Full range		6		μV/°C
	Input offset voltage long-ter (see Note 4)	m drift			25°C		0.04		μV/mo
l. a	Innut offert gurrent				25°C		1		pА
IIO	Input offset current				Full range			15	nA
1	lancet bing accompant				25°C		3		pА
ΙΒ	Input bias current				Full range			30	nA
\/	Common mode input valte				25°C	-1.6 to 4	-2 to 6		V
VICR	Common-mode input voltaç	ge range			Full range	-1.6 to 4			V
		All poeksones	D. 10 kg		25°C	3.5	3.7		V
		All packages	$R_L = 10 \text{ k}\Omega$		Full range	3			V
V/014	Maximum positive peak	FK and JG	R _L = 600 Ω		25°C	2.5	3.6		
VOM +	output voltage swing	packages	KL = 600 22	Full range	2			V	
		D and P	R _L = 100 Ω		25°C	2.5	3.1		V
		packages			Full range	2			
		All packages	R _L = 10 kΩ		25°C	-3.7	-3.9		
		All packages	17 - 10 1/22		Full range	-3			
V _{OM} –	Maximum negative peak	FK and JG	$R_1 = 600 \Omega$		25°C	-2.5	-3.5		V
VOIVI —	output voltage swing	packages	TKL = 000 32		Full range	-2			V
		D and P	R _L = 100 Ω		25°C	-2.5	-2.7		
		packages	1100 32		Full range	-2			
		All packages	$V_0 = \pm 2.8 \text{ V},$	R _L = 10 kΩ	25°C	15	80		
		, iii paonages	VU = ±2.0 V,	10 1/22	Full range	2			
			$V_0 = 0 \text{ to } 2.5 \text{ V},$	R1 = 600 O	25°C	1	65		
		FK and JG	VU = 0 10 2.0 V,	··L = 000 22	Full range	0.5			
AVD	Large-signal differential	packages	$V_0 = 0 \text{ to } -2.5 \text{ V},$	Ri = 600 O	25°C	1	16		V/mV
עעיי	voltage amplification		10 010 2.0 4,	500 22	Full range	0.5			.,,,,,,
			$V_0 = 0 \text{ to } 2 \text{ V}$	R ₁ = 100 O	25°C	0.75	45		
		D and P	$V_0 = 0 \text{ to } 2 \text{ V},$	100 22	Full range	0.5			
	packag		$V_0 = 0 \text{ to } -2 \text{ V}, R_1$	/. Rι = 100 Ω	25°C	0.5	3		
			V0 = 0 to 2 v,		Full range	0.25			

[†] Full range is – 55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated to $T_A = 25$ °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D - NOVEMBER 1989 - REVISED MAY 1996

electrical characteristics at specified free-air temperature, V_{CC \pm} = \pm 5 V (unless otherwise noted continued)

	PARAMETER	TEST CONDITIONS	T _A †	TL TL	M	UNIT	
				MIN	TYP	MAX	
rį	Input resistance		25°C		1012		Ω
ci	Input capacitance		25°C		4		pF
z _O	Open-loop output impedance	IO = 0	25°C		280		Ω
CMRR	Common-mode rejection ratio	$V_{IC} = V_{ICR}min, R_S = 50 \Omega$	25°C	65	82		dB
CIVIKK	Common-mode rejection ratio	A = A = A = A = A = A = A = A = A = A =	Full range	60			uБ
kova	Supply voltage rejection ratio (A)/a a ./A)/(a)	$V_{CC\pm} = \pm 5 \text{ V to } \pm 15 \text{ V},$	25°C	75	93		dB
ksvr	Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	$R_S = 50 \Omega$	Full range	65			uБ
la a	Cumply oursent		25°C		280	325	^
lcc	Supply current	$V_{\Omega} = 0$, No load	Full range			350	μΑ
ΔlCC	Supply-current change over operating temperature range	- 0, 100 load	Full range		39		μΑ

[†] Full range is – 55°C to 125°C.

operating characteristics, V_{CC \pm} = \pm 5 V, T_A = 25°C

	PARAMETER	т	EST CONDITIO	NS	TLE2161M TLE2161AM TLE2161BM			UNIT
					MIN	TYP	MAX	
SR	Slew rate (see Figure 1)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$,	C _L = 100 pF		10		V/μs
\/	Equivolent input poins voltage (one Figure 2)	$R_S = 20 \Omega$,	f = 10 Hz			59		->4/ -
V _n	Equivalent input noise voltage (see Figure 2)	$R_S = 20 \Omega$,	f = 1 kHz			43		nV/√Hz
V _{n(PP)}	/n(PP) Peak-to-peak equivalent input noise voltage		10 Hz	1.1			μV	
In	Equivalent input noise current					1		fA/√Hz
THD	Total harmonic distortion	$A_{VD} = 5$, $R_L = 10 \text{ k}\Omega$	$V_{O(PP)} = 2 V,$	f = 10 kHz,		0.025%		
	Cain handwidth product (and Figure 2)	f = 100 kHz,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF		5.8		MHz
	Gain-bandwidth product (see Figure 3)	f = 100 kHz,	$R_L = 600 \text{ k}\Omega$,	C _L = 100 pF		4.3		IVITZ
	Cattling time	ε = 0.1%			5			
t _S	Settling time	ε = 0.01%				10		μs
Вом	Maximum output-swing bandwidth	$A_{VD} = 5$,	R _L = 10 kΩ			420		kHz
_	Dhace margin (ace Figure 2)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF		70°		
Φm	Phase margin (see Figure 3)	A _{VD} = 5,	$R_L = 600 \Omega$,	C _L = 100 pF		84°]

TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE µPOWER OPERATIONAL AMPLIFIERS

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electrical characteristics at specified free-air temperature, V $_{\text{CC}~\pm}$ = ±15 V (unless otherwise noted)

	PARAMETE	R	TEST CON	IDITIONS	T _A †	TL	LE2161N E2161A E2161B	M	UNIT
						MIN	TYP	MAX	
		TI FOACANA			25°C		0.6	3	
		TLE2161M			Full range			6	
VIO	Input offset voltage	TLE2161AM]		25°C		0.5	1.5	mV
۷IO	iliput oliset voltage	TLLZTOTAW			Full range			3.6	IIIV
		TLE2161BM			25°C		0.3	0.5	
					Full range			1.7	
αΛΙΟ	Temperature coefficient		$V_{IC} = 0$,	$R_S = 50 \Omega$	Full range		6		μV/°C
	Input offset voltage long (see Note 4)	j-term drift			25°C		0.04		μV/mo
lio	Input offset current				25°C		2		pА
10	input onset current				Full range			20	nA
lВ	Input bias current				25°C		4		pА
,ID					Full range			40	nA
VICR	Common-mode input vo	oltage range			25°C	-11 to 13	-12 to 16		V
VICK	Common mode input ve	nage range			Full range	-11 to 13			V
		R _L = 10 kΩ		25°C	13.2	13.7			
Vom +	Maximum positive peak	output voltage swing	11 - 10 1/22		Full range	12.5			V
VOM +	waxiiilaiii positive peak	output voltage swilig	R _L = 600 Ω		25°C	12.5	13.2		v
			112 - 000 22	Full range	12				
			$R_L = 10 \text{ k}\Omega$		25°C	-13.2	-13.7		
Vom –	Maximum negative pea	k output voltage swing			Full range	-12.5			V
Olvi –		3	$R_L = 600 \Omega$		25°C	-12.5	-13		
			_		Full range	-12			
			$V_0 = \pm 10 \text{ V},$	$R_L = 10 \text{ k}\Omega$	25°C	30	230		
					Full range	20	100		
AVD	Large-signal differential	voltage amplification	$V_0 = 0 \text{ to } 8 \text{ V},$	$R_L = 600 \Omega$	25°C	25 7	100		V/mV
				-	Full range 25°C	3	25		
			$V_0 = 0 \text{ to } - 8 \text{ V},$	$R_L = 600 \Omega$	Full range	1			
r·	Input resistance				25°C	 '	1012		Ω
r _i			 		25°C	\vdash	4		
C _i	Open-loop output imped	tance	I _O = 0		25°C	\vdash	280		pF Ω
z ₀	Speri loop output litipet	Juliot	10-0	,	25°C	72	90		24
CMRR	Common-mode rejection ratio		V _{IC} = V _{ICR} min,	$R_S = 50 \Omega$	Full range	65	90		dB
			$V_{CC\pm} = \pm 5 \text{ V to}$	+15 \/	25°C	75	93		
k _{SVR}	Supply-voltage rejection	n ratio (ΔV _{CC±} /ΔV _{IO})	$R_S = 50 \Omega$	± 1 ∪ V,	Full range	65			dB
			 		25°C	 	290	350	
ICC	Supply current				Full range	\vdash		375	μΑ
ΔlCC	Supply-current change temperature range	over operating	$V_O = 0$,	No load	Full range		46	3.0	μА

[†] Full range is – 55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150$ °C extrapolated to $T_A = 25$ °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



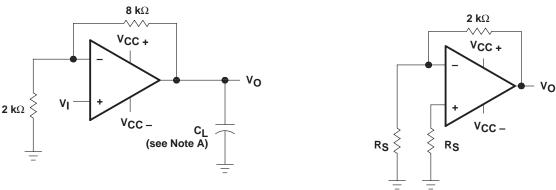
TLE2161, TLE2161A, TLE2161B EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS SLOS049D - NOVEMBER 1989 - REVISED MAY 1996

operating characteristics at specified free-air temperature, V $_{CC~\pm}$ = ± 15 V (unless otherwise noted)

	PARAMETER	TE	ST CONDITION	NS	T _A †	TI TL TL	UNIT		
						MIN	TYP	MAX	
SR	Slew rate (see Figure 1)	A _{VD} = 5,	$R_1 = 10 \text{ k}\Omega$	C _I = 100 pF	25°C	7	10		V/μs
SK	Siew rate (see rigure 1)	AVD = 3,	K_ = 10 KS2,	CL = 100 pr	Full range	5			ν/μδ
v _n	Equivalent input noise voltage	$R_S = 20 \Omega$,	f = 10 Hz		25°C		70		nV/√ Hz
٧n	(see Figure 2)	$R_S = 20 \Omega$,	f = 1 kHz		23 0		40		IIV/ VIIZ
V _{N(PP)}	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10) Hz		25°C		1.1		μV
In	Equivalent input noise current	f = 1 Hz			25°C		1.1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)} = 2 \text{ V},$ $R_L = 10 \text{ k}\Omega$	$A_{VD} = 5$,	f = 10 kHz,	25°C		0.025%		
	Gain-bandwidth product	f = 100 kHz,	$R_L = 10 \text{ k}\Omega$,	C _L = 100 pF	25°C		6.4		MHz
	(see Figure 3)	f = 100 kHz,	$R_L = 600 \Omega$,	C _L = 100 pF	25 0		5.6		IVII IZ
	Settling time	ε = 0.1%			25°C		5		
t _S	Settling time	ε = 0.01%			25 C		10		μs
ВОМ	Maximum output-swing bandwidth	A _{VD} = 5,	$R_L = 10 \text{ k}\Omega$		25°C		116		kHz
4	DI : (E: 0)	$A_{VD} = 5$,	$R_L = 10 \text{ k}\Omega$	C _L = 100 pF	2500		72°		
Φm	Phase margin (see Figure 3)	A _{VD} = 5,	$R_L = 600 \Omega$	C _L = 100 pF	25°C		78°		

[†]Full range is – 55°C to 125°C.

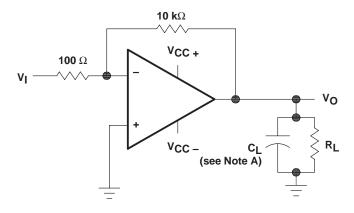
PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes fixture capacitance.

Figure 1. Slew-Rate Test Circuit

Figure 2. Noise-Voltage Test Circuit



NOTE A: C_I includes fixture capacitance.

Figure 3. Gain-Bandwidth Product and Phase-Margin Test Circuit

typical values

Typical values presented in this data sheet represent the median (50% point) of device parametric performance.

Input bias and offset current

At the picoampere bias-current level typical of the TLE2161, TLE2161A, and TLE2161B, accurate measurement of the bias current becomes difficult. Not only does this measurement require a picoammeter, but test socket leakages can easily exceed the actual device bias currents. To accurately measure these small currents, Texas Instruments uses a two-step process. The socket leakage is measured using picoammeters with bias voltages applied but with no device in the socket. The device is then inserted into the socket, and a second test that measures both the socket leakage and the device input bias current is performed. The two measurements are then subtracted algebraically to determine the bias current of the device.



TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
VIO	Input offset voltage	Distribution	4
I _{IB}	Input bias current	vs Common-mode input voltage vs Free-air temperature	5 6
I _{IO}	Input offset current	vs Free-air temperature	6
VICR	Common-mode input voltage range limits	vs Free-air temperature	7
VoM	Maximum positive peak output voltage	vs Output current	8
VoM	Maximum negative peak output voltage	vs Output current	9
Vом	Maximum peak output voltage	vs Supply voltage	10, 11, 12
VO(PP)	Maximum peak-to-peak output voltage	vs Frequency	13, 14, 15
AVD	Large-signal differential voltage amplification	vs Frequency vs Free-air temperature	16 17
los	Short-circuit output current	vs Elapsed time	18
	Large-signal voltage amplification	vs Free-air temperature	19
z _O	Output impedance	vs Frequency	20
CMRR	Common-mode rejection ratio	vs Frequency	21
ICC	Supply current	vs Supply voltage vs Free-air temperature	22 23
	Pulse response	Small signal Large signal	24, 25 26, 27
	Noise voltage (referred to input)	0.1 to 10 Hz	28
Vn	Equivalent input noise voltage	vs Frequency	29
THD	Total harmonic distortion	vs Frequency	30, 31
	Gain-bandwidth product	vs Supply voltage vs Free-air temperature	32 33
φm	Phase margin	vs Supply voltage vs Free-air temperature	34 35
	Phase shift	vs Frequency	16

TYPICAL CHARACTERISTICS[†]

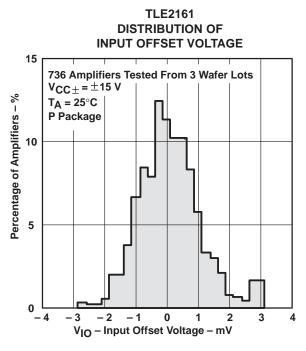
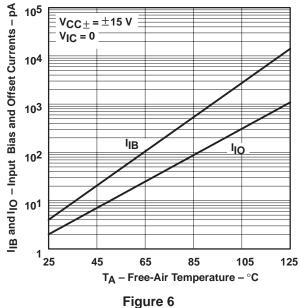


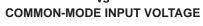
Figure 4

INPUT BIAS CURRENT AND INPUT OFFSET CURRENT

FREE-AIR TEMPERATURE



INPUT BIAS CURRENT



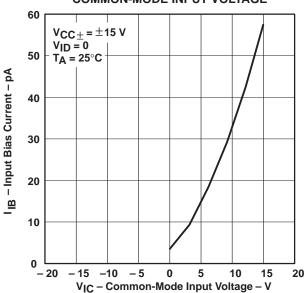


Figure 5

COMMON-MODE INPUT VOLTAGE RANGE LIMITS

FREE-AIR TEMPERATURE

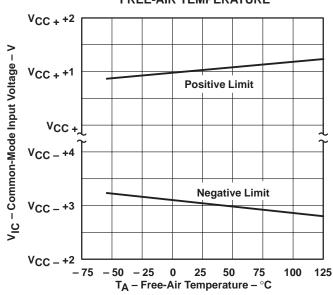


Figure 7

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



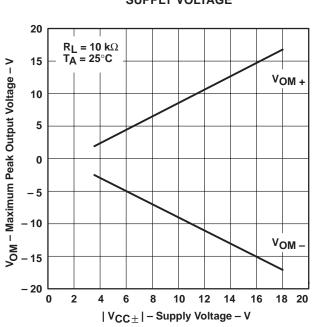
TYPICAL CHARACTERISTICS

MAXIMUM POSITIVE PEAK OUTPUT VOLTAGE OUTPUT CURRENT 16 VOM+ - Maximum Positive Peak Output Voltage - V T_A = 25°C 14 12 $V_{CC} + = \pm 15 V$ 10 8 6 $V_{CC\pm} = \pm 5 V$ 2 0 L - 20 - 30 - 40 - 50 IO - Output Current - mA

MAXIMUM NEGATIVE PEAK OUTPUT VOLTAGE vs **OUTPUT CURRENT** - 16 $T_A = 25^{\circ}C$ VOM _ - Maximum Negative Peak Output Voltage - 14 - 12 $V_{CC\pm} = \pm 15 \text{ V}$ - 10 -8 - 6 - 4 $V_{CC\pm} = \pm 5 V$ 0 0 25 5 10 15 20 30 35 40 IO - Output Current - mA

MAXIMUM PEAK OUTPUT VOLTAGE vs SUPPLY VOLTAGE

Figure 8



MAXIMUM PEAK OUTPUT VOLTAGE
vs
SUPPLY VOLTAGE

Figure 9

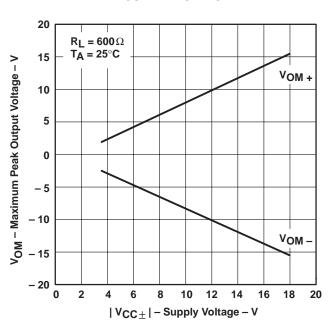


Figure 10 Figure 11

TYPICAL CHARACTERISTICS

MAXIMUM PEAK OUTPUT VOLTAGE vs SUPPLY VOLTAGE

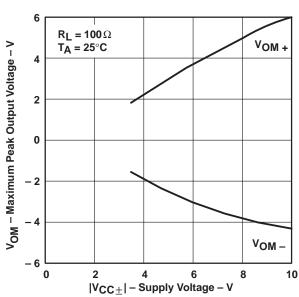


Figure 12

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE ٧s **FREQUENCY** VO(PP) - Maximum Peak-to-Peak Output Voltage - V 10 $V_{CC\pm} = \pm 5 V$ $R_L = 10 \text{ k}\Omega$ $T_A = 25^{\circ}C$ 8 6 4 2 10 k 100 k 10 M 1 M f - Frequency - Hz

Figure 13

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE

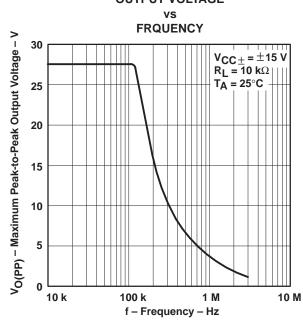
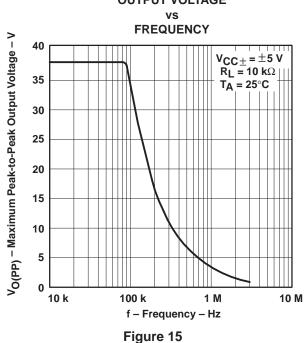


Figure 14

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE

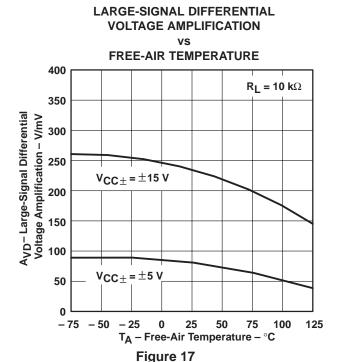




TYPICAL CHARACTERISTICS[†]

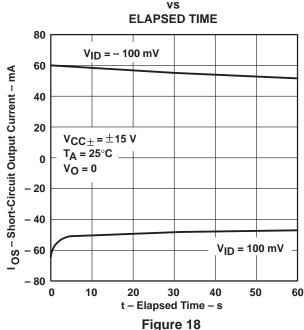
AMPLIFICATION AND PHASE SHIFT FRQUENCY 60° 120 80° 100 **Phase Shift** A_{VD}- Large-Signal Differential Voltage Amplification - dB 80 100° AVD Phase Shift 60 120° 40 140° 20 160° $V_{CC\pm} = \pm 15 \text{ V}$ $R_L = 10 \text{ k}\Omega$ 0 180° $C_{L} = 100 pF$ T_A = 25°C - 20 200° 0.1 10 100 1k 10k 100k 1M 10M f - Frequency - Hz

LARGE-SIGNAL DIFFERENTIAL VOLTAGE

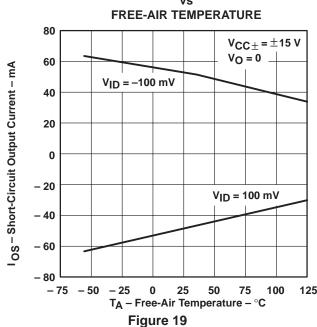


SHORT-CIRCUIT OUTPUT CURRENT vs

Figure 16



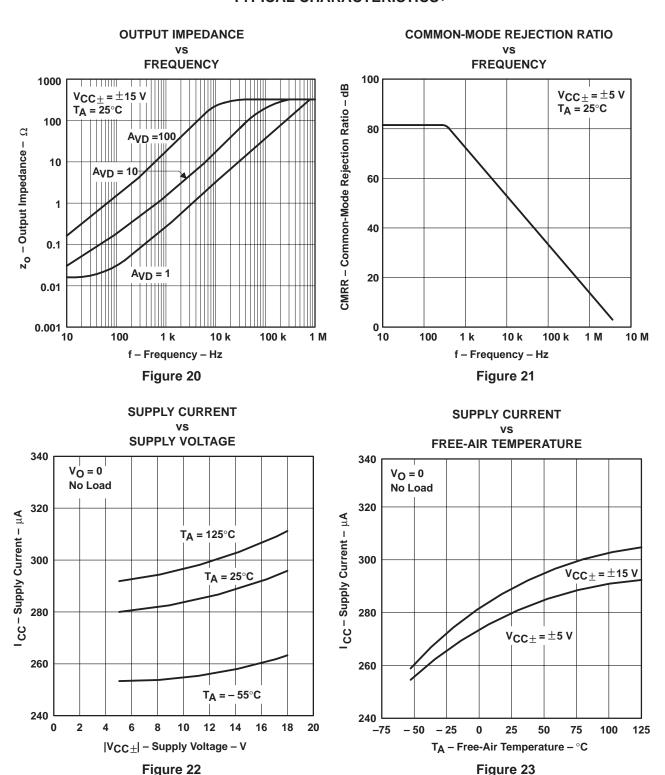
LARGE-SIGNAL VOLTAGE AMPLIFICATION vs



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS[†]



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

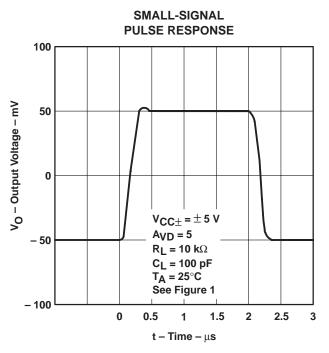


Figure 24

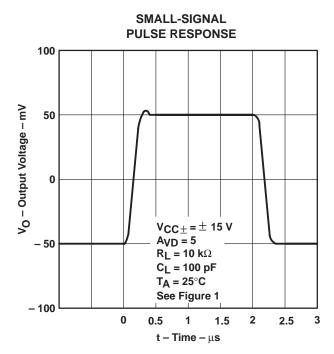
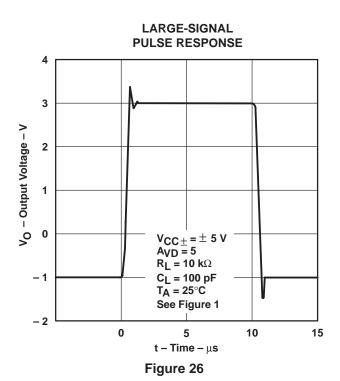


Figure 25



LARGE-SIGNAL **PULSE RESPONSE** 15 10 V_O - Output Voltage - V 5 0 $V_{CC\pm} = \pm 15 V$ - 5 $A_{VD} = 5$ $R_L = 10 \text{ k}\Omega$ C_L = 100 pF - 10 $T_A = 25^{\circ}C$ See Figure 1 - 15 10 40 $\textbf{t-Time}-\mu\textbf{s}$

Figure 27

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TYPICAL CHARACTERISTICS

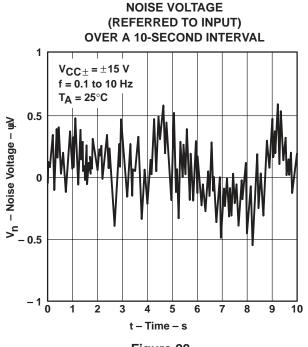


Figure 28

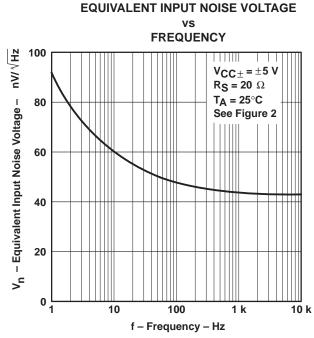
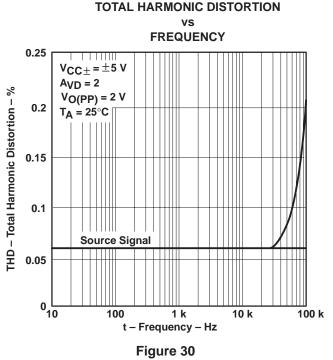


Figure 29

TOTAL HARMONIC DISTORTION

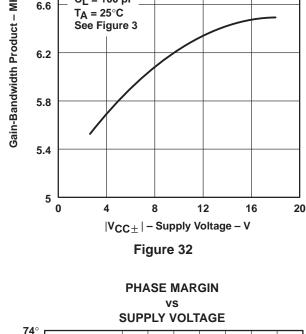


vs **FREQUENCY** 0.6 V_{CC±} = ± 5 V A_{VD} = 10 **IHD – Total Harmonic Distortion – %** 0.5 $V_{O(PP)} = 2 V$ TA = 25°C 0.4 0.3 0.2 Source Signal 0.1 0₁₀ 100 1 k 10 k 100 k f - Frequency - Hz

Figure 31

TYPICAL CHARACTERISTICS

GAIN-BANDWIDTH PRODUCT SUPPLY VOLTAGE 7 f = 100 kHz $R_L = 10 \text{ k}\Omega$ Gain-Bandwidth Product - MHz C_L = 100 pF 6.6 T_A = 25°C See Figure 3 6.2 5.8 5.4 5 0 8 12 16 20 $|V_{CC\pm}|$ – Supply Voltage – V



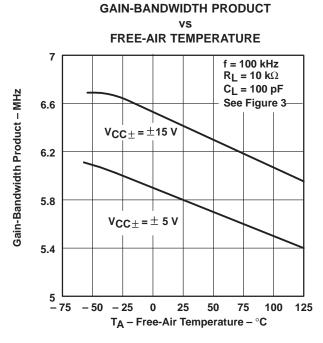


Figure 33

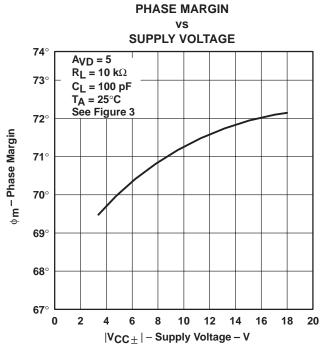


Figure 34

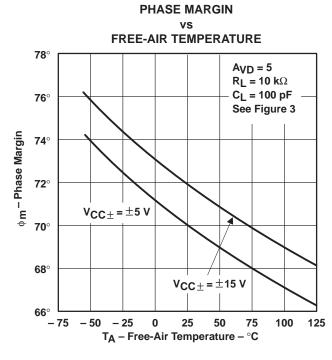


Figure 35

APPLICATION INFORMATION

macromodel information

Macromodel information provided was derived using Microsim Parts™, the model generation software used with Microsim *PSpice*™. The Boyle macromodel (see Note 5) and subcircuit in Figure 36 and Figure 37 were generated using the TLE2161 typical electrical and operating characteristics at 25°C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification

- Gain-bandwidth product
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

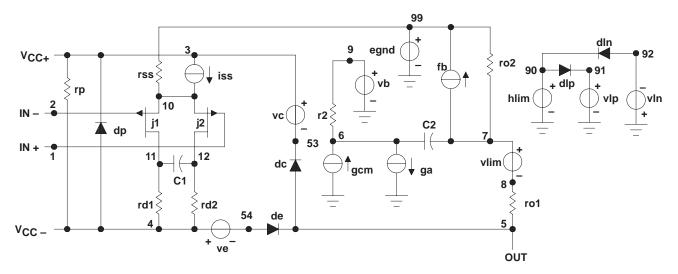


Figure 36. Boyle Macromodel

NOTE 5: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", IEEE Journal of Solid-State Circuits, SC-9, 353 (1974).

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APPLICATION INFORMATION

macromodel information (continued)

```
.subckt TLE2161 1 2 3 4 5
      11 12 125.4E-14
c1
с2
       6
              5.000E-12
dc
         53
              dx
      54 5d x
de
dlp
      90 91 dx
dln
      92
          90
             dx
dp
       4
              dx
          0 poly(2) (3,0) (4,0) 0 .5 .5
egnd
      99
         99 poly(5) vb vc ve vlp vln 0 4.085E6 -4E6 4E6 4E6 -4E6 0 11 12 201.1E-6
fb
       7
              11 12 201.1E-6
ga
       6
          6 10 99 3.576E-9
gcm
       3 10 dc 45.00E-6
iss
hlim
      90
          0
              vlim 1K
          2 10 jx
j1
      11
         1
      12
              10 jx
j2
r2
       6
           9
              100.0E3
       4 11
              4.973E3
rd1
       4 12
rd2
              4.973E3
ro1
       8
          5
              280
       7
          99
ro2
              280
       3
              113.2E3
rp
      10 99
              4.444E6
rss
vb
       9
           0
              dc 0
          53
       3
              dc 2
VC
ve
      54
          4
              dc 2
vlim
          8
              dc 0
      91
              dc 50
vlp
          0
vln
       0 92 dc 50
.model dx
          D
             (Is=800.0E-18)
.model jx PJF (Is=1.000E-12 Beta=480E-6 Vto=-1)
```

Figure 37. Macromodel Subcircuit



APPLICATION INFORMATION

input characteristics

The TLE2161, TLE2161A and TLE2161B are specified with a minimum and a maximum input voltage that if exceeded at either input could cause the device to malfunction.

Because of the extremely high input impedance and resulting low bias-current requirements, the TLE2161, TLE2161A, and TLE2161B are well suited for low-level signal processing; however, leakage currents on printed circuit boards and sockets can easily exceed bias-current requirements and cause degradation in system performance. It is a good practice to include guard rings around inputs (see Figure 38). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input.

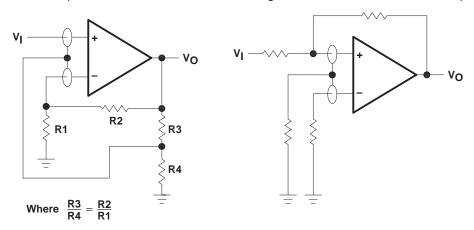


Figure 38. Use of Guard Rings

input offset voltage nulling

The TLE2161 series offers external null pins that can further reduce the input offset voltage. The circuit in Figure 39 can be connected as shown if the feature is desired. When external nulling is not needed, the null pins may be left disconnected.

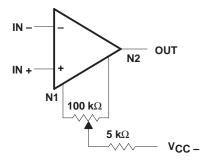


Figure 39. Input Offset Voltage Nulling







17-Dec-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
5962-9095801QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9095801QPA TLE2161M	Samples
5962-9095802QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9095802QPA TLE2161AM	Samples
5962-9095803QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9095803QPA TLE2161BM	Samples
TLE2161ACD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2161AC	Samples
TLE2161ACP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI	0 to 70		
TLE2161AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2161AI	Samples
TLE2161AIDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2161AI	Samples
TLE2161AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		2161AI	Samples
TLE2161AIP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI			
TLE2161AMJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9095802QPA TLE2161AM	Samples
TLE2161BCP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI	0 to 70		
TLE2161BIP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI			
TLE2161BMJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9095803QPA TLE2161BM	Samples
TLE2161BMP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI	-55 to 125		
TLE2161CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2161C	Samples
TLE2161CDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	2161C	Samples
TLE2161CP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI	0 to 70		
TLE2161ID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		21611	Samples
TLE2161IDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		21611	Samples



PACKAGE OPTION ADDENDUM

17-Dec-2015

Orderable Device		Package Type		Pins	_		Lead/Ball Finish		Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
TLE2161IDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		21611	Samples
TLE2161IDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		21611	Samples
TLE2161IP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI			
TLE2161MJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9095801QPA TLE2161M	Samples
TLE2161MP	OBSOLETE	PDIP	Р	8		TBD	Call TI	Call TI	-55 to 125		

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

17-Dec-2015

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- Catalog: TLE2161A, TLE2161B, TLE2161
- Military: TLE2161M, TLE2161AM, TLE2161BM

NOTE: Qualified Version Definitions:

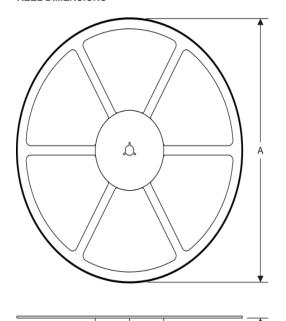
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

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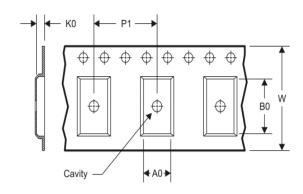
www.ti.com 14-Jul-2012

TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

All difficulties are norminal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLE2161AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2161IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLE2161IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

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*All dimensions are nominal

7 till dilliforioriorio di o riorinirial							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLE2161AIDR	SOIC	D	8	2500	340.5	338.1	20.6
TLE2161IDR	SOIC	D	8	2500	367.0	367.0	35.0
TLE2161IDR	SOIC	D	8	2500	340.5	338.1	20.6

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